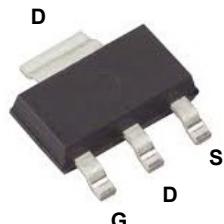
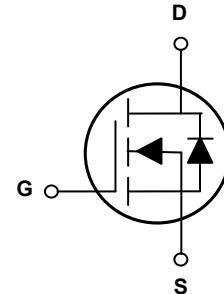


Main Product Characteristics

$V_{(BR)DSS}$	200V
$R_{DS(ON)}$	700mΩ (Max.)
I_D	4A



SOT-223



Schematic Diagram

Features and Benefits

- Advanced MOSFET process technology
- Ideal for high efficiency switched mode power supplies
- Low on-resistance with low gate charge
- Fast switching and reverse body recovery



Description

The GSFL2004 utilizes the latest techniques to achieve high cell density and low on-resistance. These features make this device extremely efficient and reliable for use in high efficiency switch mode power supplies and a wide variety of other applications.

Absolute Maximum Ratings ($T_C=25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Max.	Unit
Drain-Source Voltage	V_{DS}	200	V
Gate-Source Voltage	V_{GS}	± 20	V
Drain Current-Continuous ($T_A=25^\circ\text{C}$)	I_D	4	A
Drain Current-Continuous ($T_A=100^\circ\text{C}$)		2.8	
Drain Current-Pulsed ¹	I_{DM}	16	A
Single Pulse Avalanche Energy ²	E_{AS}	10.6	mJ
Power Dissipation ($T_A=25^\circ\text{C}$)	P_D	30	W
Power Dissipation-Derate above 25°C		0.24	W/°C
Thermal Resistance, Junction-to-Case	$R_{\theta JC}$	4.17	°C/W
Operating Junction Temperature Range	T_J	-55 To +150	°C
Storage Temperature Range	T_{STG}	-55 To +150	°C

Electrical Characteristics ($T_J=25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
On / Off Characteristics						
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{\text{GS}}=0\text{V}, I_{\text{D}}=250\mu\text{A}$	200	-	-	V
BV_{DSS} Temperature Coefficient	$\Delta \text{BV}_{\text{DSS}}/\Delta T_J$	Reference to 25°C , $I_{\text{D}}=1\text{mA}$	-	0.055	-	V°C
Drain-Source Leakage Current	I_{DSS}	$V_{\text{DS}}=200\text{V}, V_{\text{GS}}=0\text{V}, T_J=25^\circ\text{C}$	-	-	1	μA
		$V_{\text{DS}}=160\text{V}, V_{\text{GS}}=0\text{V}, T_J=125^\circ\text{C}$	-	-	10	μA
Gate-Source Leakage Current	I_{GSS}	$V_{\text{GS}}=\pm 20\text{V}, V_{\text{DS}}=0\text{V}$	-	-	± 100	nA
Static Drain-Source On-Resistance	$R_{\text{DS(ON)}}$	$V_{\text{GS}}=10\text{V}, I_{\text{D}}=3\text{A}$	-	510	700	$\text{m}\Omega$
		$V_{\text{GS}}=4.5\text{V}, I_{\text{D}}=2\text{A}$	-	550	750	
Gate Threshold Voltage	$V_{\text{GS(th)}}$	$V_{\text{GS}}=V_{\text{DS}}, I_{\text{D}}=250\mu\text{A}$	1.0	1.8	2.9	V
$V_{\text{GS(th)}}$ Temperature Coefficient	$\Delta V_{\text{GS(th)}}$		-	-5	-	mV°C
Forward Transconductance	g_{fs}	$V_{\text{DS}}=10\text{V}, I_{\text{D}}=3\text{A}$	-	8	-	S
Dynamic and Switching Characteristics						
Total Gate Charge ^{2,3}	Q_g	$V_{\text{DS}}=100\text{V}, V_{\text{GS}}=10\text{V}, I_{\text{D}}=4\text{A}$	-	12.6	-	nC
Gate-Source Charge ^{2,3}	Q_{gs}		-	2.1	-	
Gate-Drain Charge ^{2,3}	Q_{gd}		-	2.2	-	
Turn-On Delay Time ^{2,3}	$t_{\text{d(on)}}$	$V_{\text{DD}}=100\text{V}, V_{\text{GS}}=10\text{V}, R_{\text{G}}=5\Omega, I_{\text{D}}=4\text{A}$	-	13	-	nS
Rise Time ^{2,3}	t_r		-	10	-	
Turn-Off Delay Time ^{2,3}	$t_{\text{d(off)}}$		-	40	-	
Fall Time ^{2,3}	t_f		-	10	-	
Input Capacitance	C_{iss}	$V_{\text{DS}}=30\text{V}, V_{\text{GS}}=0\text{V}, F=1\text{MHz}$	-	775	-	pF
Output Capacitance	C_{oss}		-	12.5	-	
Reverse Transfer Capacitance	C_{rss}		-	4.4	-	
Gate Resistance	R_g	$V_{\text{GS}}=0\text{V}, V_{\text{DS}}=0\text{V}, F=1\text{MHz}$	-	1.4	3	Ω
Source-Drain Ratings and Characteristics						
Continuous Source Current	I_s	$V_G=V_D=0\text{V}$, Force Current	-	-	4	A
Pulsed Source Current	I_{SM}		-	-	16	A
Diode Forward Voltage	V_{SD}	$V_{\text{GS}}=0\text{V}, I_{\text{S}}=2\text{A}, T_J=25^\circ\text{C}$	-	-	1.2	V
Reverse Recovery Time ²	T_{rr}	$V_R=50\text{V}, I_{\text{S}}=4\text{A}, d_i/d_t=100\text{A}/\mu\text{s}, T_J=25^\circ\text{C}$	-	86	-	nS
Reverse Recovery Charge ²	Q_{rr}		-	280	-	nC

Notes:

- Repetitive rating: Pulsed width limited by maximum junction temperature.
- $V_{\text{DD}}=40\text{V}, V_{\text{GS}}=10\text{V}, L=0.5\text{mH}, R_{\text{G}}=25\Omega$, starting $T_J=25^\circ\text{C}$.
- Pulse test: pulse width $\leq 300\mu\text{s}$, duty cycle $\leq 2\%$.
- Essentially independent of operating temperature.

Typical Electrical and Thermal Characteristic Curves

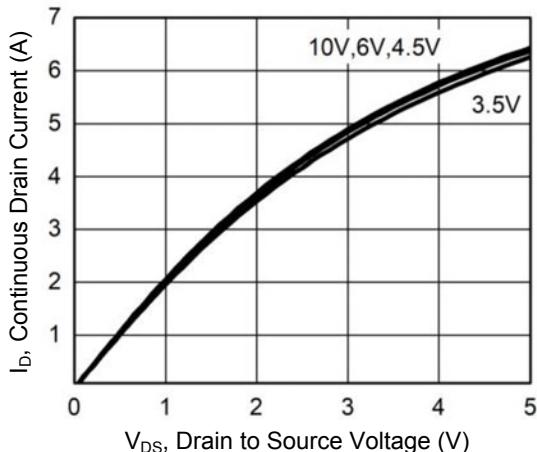


Figure 1. Typical Output Characteristics

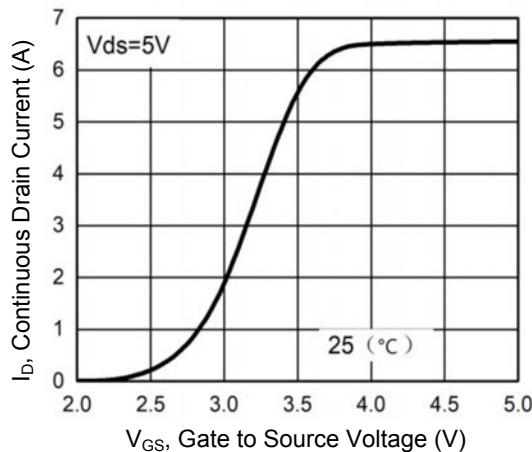


Figure 2. Transfer Characteristics

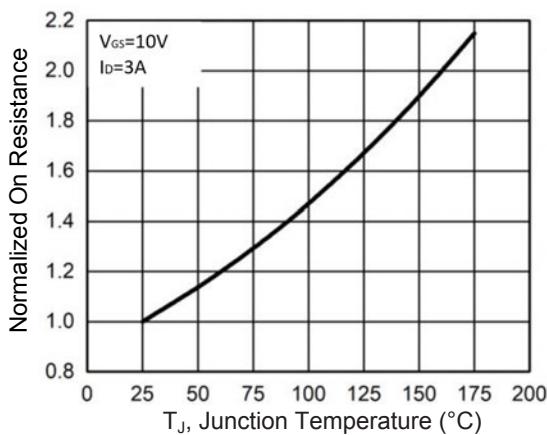


Figure 3. Normalized $R_{DS(\text{ON})}$ vs. T_J

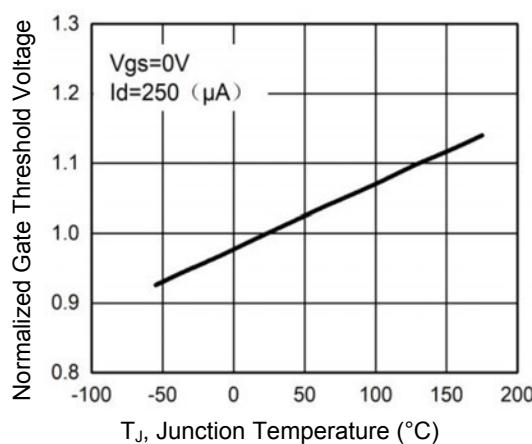


Figure 4. Normalized BV_{DSS} vs. T_J

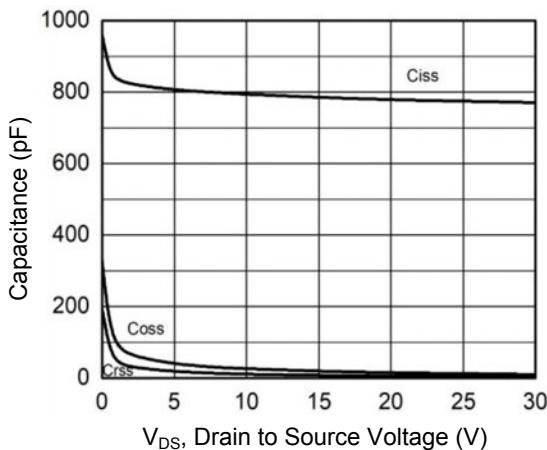


Figure 5. Capacitance Characteristics

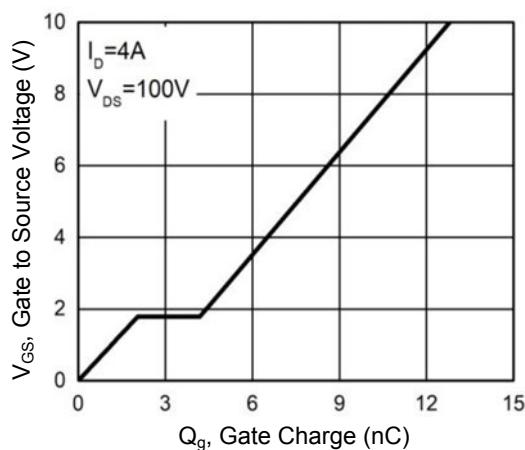
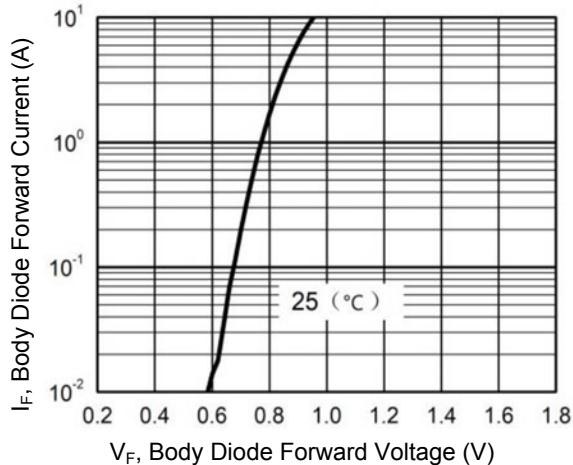


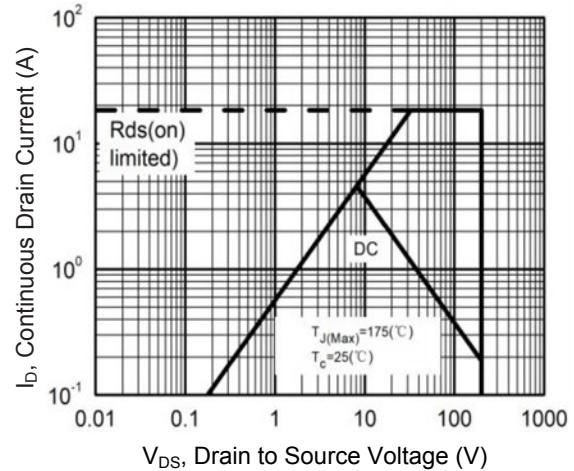
Figure 6. Gate Charge Waveform

Typical Electrical and Thermal Characteristic Curves



V_F , Body Diode Forward Voltage (V)

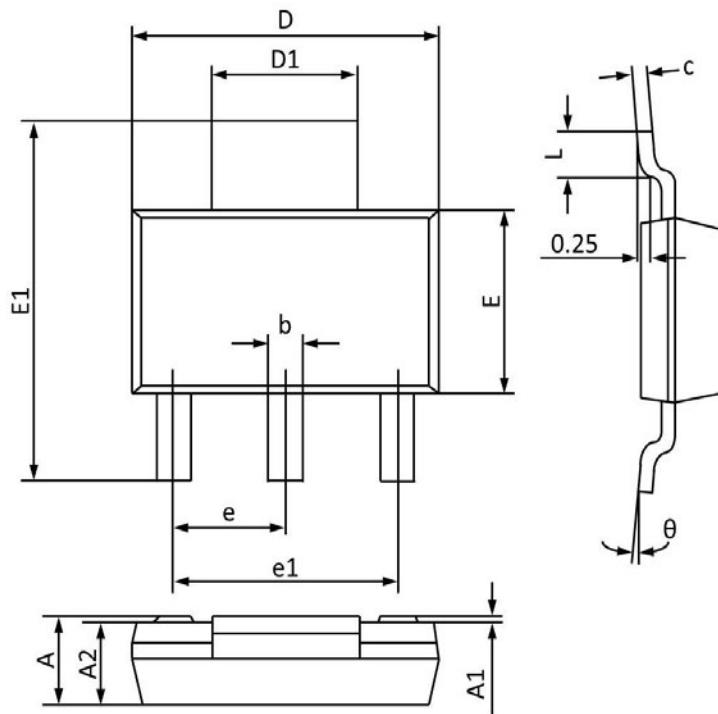
Figure 7. Body Diode Characteristics



I_D , Continuous Drain Current (A)
 V_{DS} , Drain to Source Voltage (V)

Figure 8. Maximum Safe Operation Area

Package Outline Dimensions (SOT-223)



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min	Max	Min	Max
A	1.50	1.80	0.060	0.071
A1	0.00	0.12	0.000	0.005
A2	1.45	1.75	0.057	0.069
b	0.60	0.82	0.024	0.032
c	0.20	0.35	0.008	0.014
D	6.20	6.70	0.244	0.264
D1	2.90	3.10	0.114	0.122
E	3.30	3.70	0.130	0.146
E1	6.70	7.30	0.264	0.287
e	2.30 BSC		0.091 BSC	
e1	4.40	4.70	0.173	0.185
L	0.90	1.15	0.035	0.045
θ	0°	10°	0°	10°